



General Description

These N+P dual Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BV _{DSS}	R _{DS(ON)}	Ι _D
100 V	120 mΩ	8.8 A
-100 V	300 mΩ	-4.8 A

Features

- Fast Switching
- · Green Device Available

SOP-8 Pin Configuration

	D1	D2 γ
D2 ^{D2}	ے ا	
D1 D2	(- 5	
D1	G1 (◄¬▲)G2	(!▶ ¬₹ <i>)</i>
G2		
S1 ^{G1} S2	ļ	
S1 ^{G1}	S1	S2 ^o

Applications

• BLDC

Absolute Maximum Ratings T _c =25°C unless otherwise noted									
Symbol	Parameter		Rating		Units				
V _{DS}	Drain-Source Voltage		100	-100	V				
V_{GS}	Gate-Source Voltage		±20	±20	V				
I _D	Drain Current - Continuous (T _C =25°C)		8.8	-4.8	Α				
I _{DM}	Drain Current - Pulsed (NOTE 1)		28	-14.8	Α				
P _D	Power Dissipation (T _C =25°C)		23	3.1	W				
T_J	Operating Junction Temperature Range		-55 to 150		°C				
T _{STG}	Storage Temperature Range		-55 to 150		°C				
Marking Code			BM120 ,	AP5G10S					

Thermal Characteristics								
Symbol	Parameter	Rating	Unit					
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	62.5	°C/W					
$R_{ heta JC}$	· · · · · · · · · · · · · · · · · · ·		°C/W					





N Channel Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I_D =250uA	100			V
I _{DSS}	Drain-Source Leakage Current	V _{DS} =100V , V _{GS} =0V			1	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} =±20V , V_{DS} =0V			±100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R _{DS(ON)}	IStatic Drain-Source On-Resistance	V_{GS} =10V , I_D =5A			120	mΩ
		V_{GS} =4.5V , I_D =3A			150	11122
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250uA$	1.2		2.5	V
gfs	Forward Transconductance	V_{DS} =5V , I_{D} =5A		14		S

Dynamic and Switching Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Q_g	Total Gate Charge			11.9		
Q_{gs}	Gate-Source Charge	V_{DS} =50V , V_{GS} =10V , I_{D} =5A		2.8		nC
Q_{gd}	Gate-Drain Charge			1.7		
$T_{d(on)}$	Turn-On Delay Time			3.8		
T _r	Rise Time	V_{DS} =30V , V_{GS} =10V , R_{G} =1.8 Ω ,		25.8		nS
$T_{d(off)}$	Turn-Off Delay Time	I _D =5A		16		113
T_f	Fall Time			8.8		
C _{iss}	Input Capacitance			1100		
C_{oss}	Output Capacitance	V_{DS} =15V , V_{GS} =0V , F=1MHz		55		pF
C_{rss}	Reverse Transfer Capacitance			40		
R_g	Gate Resistance	V_{DS} =0V , V_{GS} =0V , F=1MHz		3		Ω

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current	V _G =V _D =0V , Force Current			8.8	Α
V_{SD}	Diode Forward Voltage	V_{GS} =0V , I_{S} =1A			1.2	V

NOTES:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.
- 3. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.





Characteristics Curves

FIG. 1-Output Characteristics

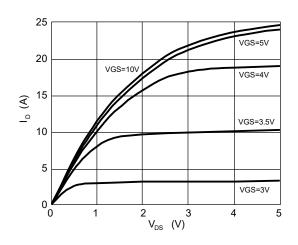


FIG. 2-Transfer Characteristics

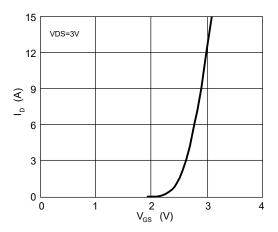


FIG. 3-Forward Characteristics of Body Diode

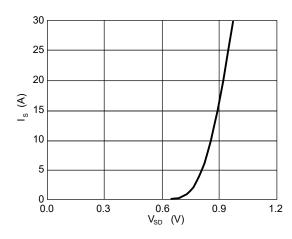


FIG. 4-Gate Charge Characteristics

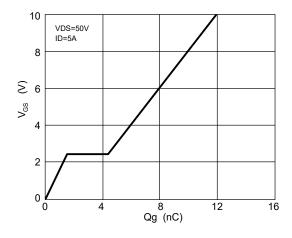


FIG. 5- $R_{DS(ON)}$ vs V_{GS}

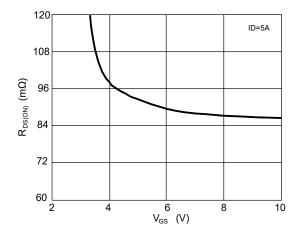
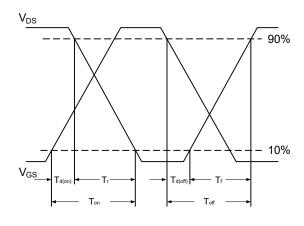


FIG. 6-Switching Time Waveform







P Channel Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0V , I_D = -250uA	-100			V
I _{DSS}	Drain-Source Leakage Current	V _{DS} = -100V , V _{GS} = 0V			-1	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = ±20V , V_{DS} = 0V			±100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R _{DS(ON)}	IStatic Drain-Source On-Resistance	V_{GS} = -10V , I_D = -5A		-	300	mΩ
		V _{GS} = -4.5V , I _D = -3A			340	11122
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=-250uA$	-1.2		-2.5	V

Dynamic and switching Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Q_g	Total Gate Charge	V = 50V V = 10V		11.5		
Q_{gs}	Gate-Source Charge	-V _{DD} = -50V , V _{GS} = -10V , -I _D = -5A		1.3		nC
Q_{gd}	Gate-Drain Charge	1 _D 5/1		2.9		
$T_{d(on)}$	Turn-On Delay Time			12		
T _r	Rise Time	V _{DS} = -50V , V _{GEN} = -10V ,		5		nS
$T_{d(off)}$	Turn-Off Delay Time	R_G = 4.5 Ω , R_L =25 Ω , I_D = -5A		35		110
T_f	Fall Time	7		20		
C_{iss}	Input Capacitance			760		
C_{oss}	Output Capacitance	V_{DS} = -50V , V_{GS} = 0V , F= 1MHz		25		pF
C_{rss}	Reverse Transfer Capacitance	7		12		

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			-4.8	Α
V_{SD}	Diode Forward Voltage	V_{GS} =0V , I_S = -1A			-1.3	V
t _{rr}	Reverse Recovery Time	V_{GS} =0V , I_{SD} = -3A ,		25		nS
Q_{rr}	Reverse Recovery Charge	di/dt=100A/us		20		nC

NOTES:

- 4. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



S8MBM120



100V N+P Dual Channel MOSFETs

Characteristics Curves

FIG. 7-Output Characteristics

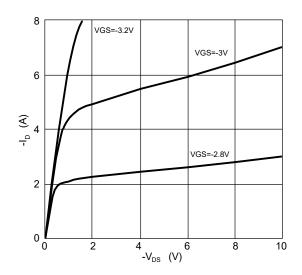


FIG. 9-Normalized $R_{DS(ON)}$ vs T_J

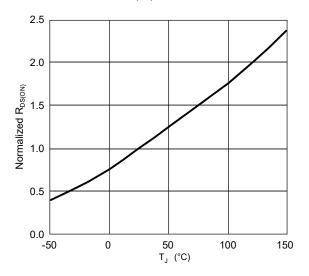


FIG. 11- $R_{DS(ON)}$ vs V_{GS}

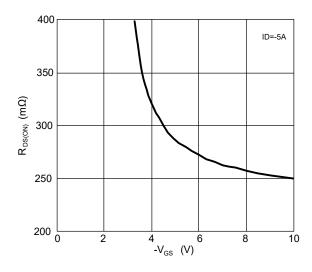


FIG. $8-I_D$ vs T_C

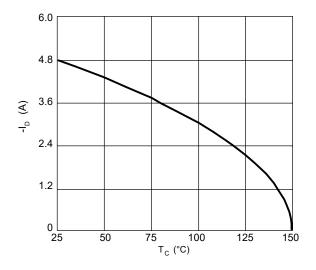


FIG. 10-Normalized $V_{GS(th)}$ vs T_J

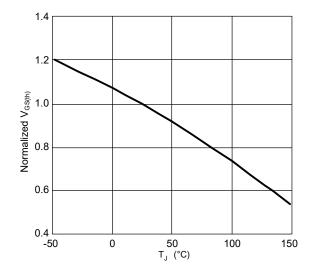
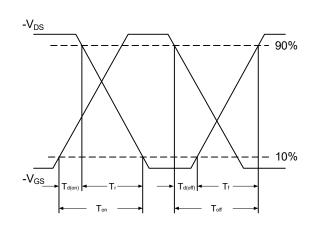


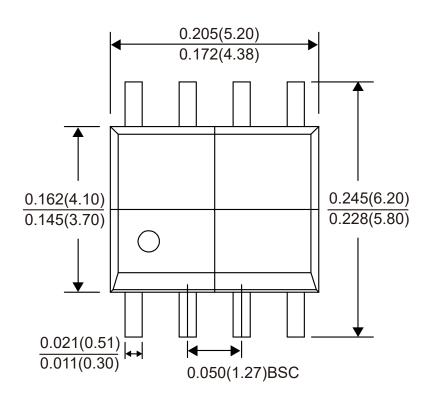
FIG. 12-Switching Time Waveform

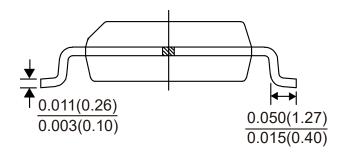


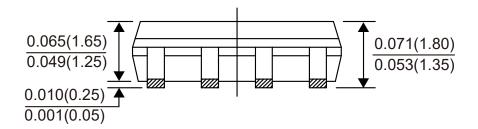




Package Outline Dimensions







SOP-8Dimensions in inches and (millimeters)





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